

## AO3400

# **N-Channel Enhancement Mode Field Effect Transistor**



## **General Description**

The AO3400 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications. Standard Product AO3400 is Pb-free (meets ROHS & Sony 259 specifications). AO3400L is a Green Product ordering option. AO3400 and AO3400L are electrically identical.

#### **Features**

 $V_{DS}(V) = 30V$ 

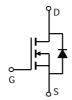
 $I_D = 5.8 \text{ A } (V_{GS} = 10 \text{V})$ 

 $R_{DS(ON)}$  < 28m $\Omega$  ( $V_{GS}$  = 10V)

 $R_{DS(ON)}$  < 33m $\Omega$  ( $V_{GS}$  = 4.5V)

 $R_{DS(ON)}$  < 52m $\Omega$  ( $V_{GS}$  = 2.5V)





| Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted |                      |                   |            |       |  |  |  |  |
|----------------------------------------------------------------------|----------------------|-------------------|------------|-------|--|--|--|--|
| Parameter                                                            |                      | Symbol            | Maximum    | Units |  |  |  |  |
| Drain-Source Voltage                                                 |                      | $V_{DS}$          | 30         | V     |  |  |  |  |
| Gate-Source Voltage                                                  |                      | $V_{GS}$          | ±12        | V     |  |  |  |  |
| Continuous Drain                                                     | T <sub>A</sub> =25°C |                   | 5.8        |       |  |  |  |  |
| Current <sup>A</sup>                                                 | T <sub>A</sub> =70°C | I <sub>D</sub>    | 4.9        | А     |  |  |  |  |
| Pulsed Drain Current <sup>B</sup>                                    |                      | I <sub>DM</sub>   | 30         |       |  |  |  |  |
|                                                                      | T <sub>A</sub> =25°C | $P_{D}$           | 1.4        | W     |  |  |  |  |
| Power Dissipation A                                                  | T <sub>A</sub> =70°C | FD                | 1          | - vv  |  |  |  |  |
| Junction and Storage Temperature Range                               |                      | $T_J$ , $T_{STG}$ | -55 to 150 | °C    |  |  |  |  |

| Thermal Characteristics               |              |                                          |     |     |       |  |  |
|---------------------------------------|--------------|------------------------------------------|-----|-----|-------|--|--|
| Parameter                             |              | Symbol                                   | Тур | Max | Units |  |  |
| Maximum Junction-to-Ambient A         | t ≤ 10s      | t ≤ 10s<br>Steady-State R <sub>θJA</sub> |     | 90  | °C/W  |  |  |
| Maximum Junction-to-Ambient A         | Steady-State |                                          |     | 125 | °C/W  |  |  |
| Maximum Junction-to-Lead <sup>C</sup> | Steady-State | $R_{\theta JL}$                          | 43  | 60  | °C/W  |  |  |

## Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

| Symbol              | Parameter                             | Conditions                                                                |                       | Min  | Тур  | Max  | Units |  |  |
|---------------------|---------------------------------------|---------------------------------------------------------------------------|-----------------------|------|------|------|-------|--|--|
| STATIC PARAMETERS   |                                       |                                                                           |                       |      |      |      |       |  |  |
| $BV_{DSS}$          | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                |                       | 30   |      |      | V     |  |  |
| I <sub>DSS</sub>    | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =24V, V <sub>GS</sub> =0V                                 |                       |      |      | 1    | μА    |  |  |
|                     |                                       |                                                                           | T <sub>J</sub> =55°C  |      |      | 5    | μΑ    |  |  |
| $I_{GSS}$           | Gate-Body leakage current             | $V_{DS}$ =0V, $V_{GS}$ =±12V                                              |                       |      |      | 100  | nA    |  |  |
| $V_{GS(th)}$        | Gate Threshold Voltage                | $V_{DS}=V_{GS} I_{D}=250\mu A$                                            |                       | 0.7  | 1.1  | 1.4  | V     |  |  |
| $I_{D(ON)}$         | On state drain current                | V <sub>GS</sub> =4.5V, V <sub>DS</sub> =5V                                |                       | 30   |      |      | Α     |  |  |
| R <sub>DS(ON)</sub> | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =5.8A                                |                       |      | 22.8 | 28   | mΩ    |  |  |
|                     |                                       |                                                                           | T <sub>J</sub> =125°C |      | 32   | 39   | 11122 |  |  |
|                     |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =5A                                 |                       |      | 27.3 | 33   | mΩ    |  |  |
|                     |                                       | $V_{GS}$ =2.5V, $I_D$ =4A                                                 |                       | 43.3 | 52   | mΩ   |       |  |  |
| <b>9</b> FS         | Forward Transconductance              | $V_{DS}$ =5V, $I_{D}$ =5A                                                 | 10                    | 15   |      | S    |       |  |  |
| $V_{SD}$            | Diode Forward Voltage                 | I <sub>S</sub> =1A,V <sub>GS</sub> =0V                                    |                       | 0.71 | 1    | V    |       |  |  |
| Is                  | Maximum Body-Diode Continuous Current |                                                                           |                       |      |      | 2.5  | Α     |  |  |
| DYNAMIC             | PARAMETERS                            |                                                                           |                       |      |      |      |       |  |  |
| C <sub>iss</sub>    | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                         |                       |      | 823  | 1030 | pF    |  |  |
| Coss                | Output Capacitance                    |                                                                           |                       |      | 99   |      | pF    |  |  |
| C <sub>rss</sub>    | Reverse Transfer Capacitance          |                                                                           |                       |      | 77   |      | pF    |  |  |
| $R_g$               | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                          |                       |      | 1.2  | 3.6  | Ω     |  |  |
| SWITCHI             | NG PARAMETERS                         | •                                                                         | ·                     |      | •    | •    |       |  |  |
| $Q_g$               | Total Gate Charge                     | V <sub>GS</sub> =4.5V, V <sub>DS</sub> =15V, I <sub>D</sub> =5.8A         |                       |      | 9.7  | 12   | nC    |  |  |
| $Q_{gs}$            | Gate Source Charge                    |                                                                           |                       |      | 1.6  |      | nC    |  |  |
| $Q_{gd}$            | Gate Drain Charge                     |                                                                           |                       |      | 3.1  |      | nC    |  |  |
| t <sub>D(on)</sub>  | Turn-On DelayTime                     |                                                                           |                       |      | 3.3  | 5    | ns    |  |  |
| t <sub>r</sub>      | Turn-On Rise Time                     | $V_{GS}$ =10V, $V_{DS}$ =15V, $R_L$ =2.7 $\Omega$ , $R_{GEN}$ =3 $\Omega$ |                       |      | 4.8  | 7    | ns    |  |  |
| t <sub>D(off)</sub> | Turn-Off DelayTime                    |                                                                           |                       |      | 26.3 | 40   | ns    |  |  |
| t <sub>f</sub>      | Turn-Off Fall Time                    |                                                                           |                       |      | 4.1  | 6    | ns    |  |  |
| t <sub>rr</sub>     | Body Diode Reverse Recovery Time      | I <sub>F</sub> =5A, dI/dt=100A/μs                                         |                       |      | 16   | 20   | ns    |  |  |
| Q <sub>rr</sub>     | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =5A, dI/dt=100A/μs                                         |                       |      | 8.9  | 12   | nC    |  |  |

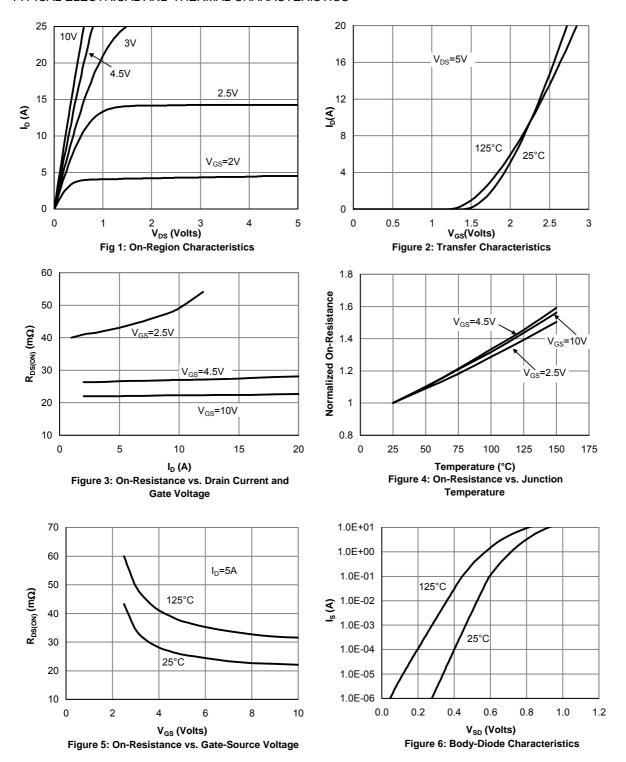
A: The value of  $R_{\theta JA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A$  =25°C. The value in any given application depends on the user's specific board design. The current rating is based on the  $\bowtie$  10s thermal resistance rating.

- B: Repetitive rating, pulse width limited by junction temperature.
- C. The R  $_{\theta JA}$  is the sum of the thermal impedence from junction to lead  $R_{\theta JL}$  and lead to ambient.
- D. The static characteristics in Figures 1 to 6,12,14 are obtained using  $80\mu s$  pulses, duty cycle 0.5% max.
- E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25°C. The SOA curve provides a single pulse rating.

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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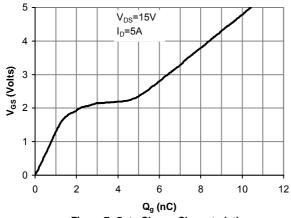


Figure 7: Gate-Charge Characteristics

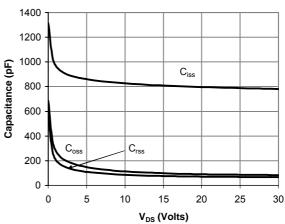


Figure 8: Capacitance Characteristics

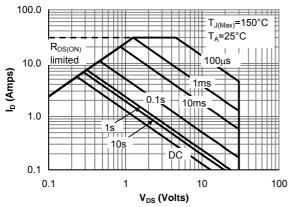


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

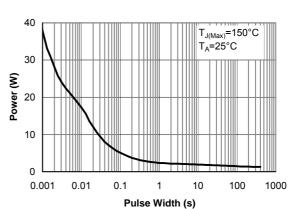


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

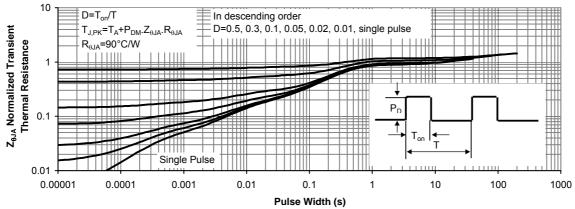


Figure 11: Normalized Maximum Transient Thermal Impedance